10/585821 IAP6 Rec'd PCT/PTO 12 JUL 2006

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Yuichiro OGAWA

Application No.: New U.S. Patent Application

Filed: July 12, 2006 Docket No.: 128594

For: METHOD FOR MANUFACTURING TIRES

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 7 9.
- 3. One or more reference cited herein was cited in the International Search Report. A copy of the International Search Report is attached for the Examiner's information. See References 10 17.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 7 13 and 15 17.

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New U.S. PCT/JP2004/019557

6. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 7 - 9, 11, 13 and 15 - 17.

7. References 1 and 2 correspond to reference 7. References 3-6 correspond to references 8, 13, 15 and 16, respectively.

Respectfully submitte

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JAO:DAT/jtp

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Sheet 1 of 1 Form PTO-1449 ATTY DOCKET NO. APPLICATION NO. US Dept. of Commerce (REV. 1/06) PATENT & TRADEMARK OFFICE 128594 New U.S. National Phase of PCT/JP2004/019557 INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) APPLICANT Yuichiro OGAWA FILING DATE July 12, 2006 U.S. PATENT DOCUMENTS Cite Examiner Initials Document Number Date Name 1 6,085,817 7/11/2000 **OGAWA** 2 6,613,173 B1 9/2/2003 **OGAWA** 3 **OGAWA** 6,328,836 B1 12/11/2001 4 2002/0003014 1/10/2002 BAUMANN, et al. 5 2002/0157753 10/31/2002 CARETTA, et al. 6 5,885,387 3/23/1999 **UEYOKO** FOREIGN PATENT DOCUMENTS With With Examiner Cite Date Initials Document Number Country English English No. Abstract Translation 7 JP A 11-115420 4/27/1999 х Japan Х 8 JP A 2000-52448 2/22/2000 Х Х Japan 9 JP A 2002-127268 5/8/2002 \mathbf{x} Х Japan 10 WO 03/89258 A1 10/30/2003 **WIPO** Х JP A 2003-159909 11 6/3/2003 \mathbf{x} Х Japan 12 WO 02/083434 A1 10/24/2002 **WIPO** Х JP A 2000-142042 5/23/2000 \mathbf{x} 13 Х Japan 14 WO 02/30691 A1 4/18/2002 **WIPO** 15 JP A 2003-528761 9/30/2003 Х Japan X JP A 9-155991 6/17/1997 Х х 16 Japan 17 JP A 2005-22537 1/27/2005 X Х Japan OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) Examiner Cite Initials

EXAMINER DATE CONSIDERED

Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: July 12, 2006

Examiner: